

NOV 16 2006

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. .... 10/820,575  
Filing Date .... April 7, 2004  
Inventor .... Scott E. Moore et al.  
Assignee .... Micron Technology, Inc.  
Group Art Unit .... 2877  
Examiner .... Roy Punnoose  
Attorney's Docket No. .... MI22-2493  
Title: Semiconductor Workpiece Processing Methods and Turbidity Monitoring Methods

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References – See Attached Form PTO-1449

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. No admission is made regarding whether all the submitted references are prior art.

Respectfully submitted,

Dated: 11/16/06By: James D. Shaurette  
Reg. No. 39,833

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|---|----|--|----------|------------------------------------|-------|--------------------------|----------------------------|
| Form PTO-1449   |    | U.S. DEPARTMENT OF COMMERCE<br>PATENT AND TRADEMARK OFFICE |          | ATTY. DOCKET NO.<br>MI22-2493      |       | SERIAL NO.<br>10/B20,575 |                            |
| LIST OF ART CITED BY APPLICANT<br>(Use several sheets if necessary)   |    |  |          | APPLICANT<br>Scott E. Moore et al. |       |                          |                            |
|   |    |  |          | FILING DATE<br>April 7, 2004       |       | GROUP<br>1734            |                            |
| U.S. PATENT DOCUMENTS   |    |  |          |                                    |       |                          |                            |
| *Examiner Initial   |    | Document Number  | Date     | Name                               | Class | Subclass                 | Filing Date If Appropriate |
|   | AA | 5,865,665  | 2/2/1999 | Yueh                               |       |                          |                            |
|   | AB | 6,207,921  | 5/4/1993 | Vincent, John D.                   |       |                          |                            |
|   | AC | 3,809,243  | 5/7/1974 | Teders, Philip J.                  |       |                          |                            |
|   | AD |  |          |                                    |       |                          |                            |
|   | AE |  |          |                                    |       |                          |                            |
|   | AF |  |          |                                    |       |                          |                            |
|   | AG |  |          |                                    |       |                          |                            |
|   | AH |  |          |                                    |       |                          |                            |
|   | AI |  |          |                                    |       |                          |                            |
|   | AJ |  |          |                                    |       |                          |                            |
|   | AK |  |          |                                    |       |                          |                            |
|   | AL |  |          |                                    |       |                          |                            |
|   | AM |  |          |                                    |       |                          |                            |
|   | AQ |  |          |                                    |       |                          |                            |
| FOREIGN PATENT DOCUMENTS  |    |  |          |                                    |       |                          |                            |
|   |    | Document Number  | Date     | Country                            | Class | Subclass                 | Translation                |
|   | AR |  |          |                                    |       |                          | Yes   No                   |
|   | AS |  |          |                                    |       |                          |                            |
|   | AV |  |          |                                    |       |                          |                            |
| OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)   |    |  |          |                                    |       |                          |                            |
| EXAMINER  |    |  |          | DATE CONSIDERED                    |       |                          |                            |
| *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. |    |  |          |                                    |       |                          |                            |